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TAPE MEASURE (54)

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- 14 Years (**) Term:
- Appl. No.: 29/129,494 (21)

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CLAIM (57)

The ornamental design for a tape measure, as shown and described.

DESCRIPTION

(22)	Filed: Sep. 13, 2000	
	LOC (7) Cl.	
(52)	U.S. Cl.	
	Field of Search	
(56)	References Cited	
	U.S. PATENT DOCUMENTS	

- D. 350,703 * 9/1994 Fifer D10/72 D. 419,081 * 1/2000 Evans, Jr. et al. D10/72
- * cited by examiner

FIG. 1 is a perspective view of a tape measure showing my new design;

- FIG. 2 is a front elevational view thereof; FIG. 3 is a rear elevational view thereof;
- FIG. 4 is a top plan view thereof;
- FIG. 5 is a bottom plan view thereof;
- FIG. 6 is a left side elevational view thereof; and, FIG. 7 is a right side elevational view thereof.

1 Claim, 4 Drawing Sheets



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FIG.4



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FIG.6

